

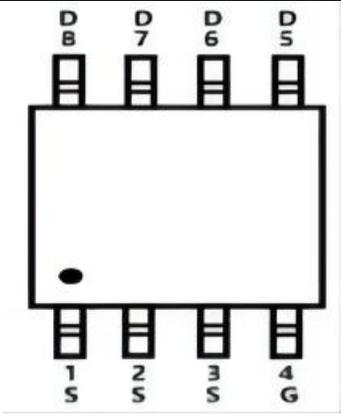
**LSR4407S8 30V P-Channel MOSFET**
**Features**

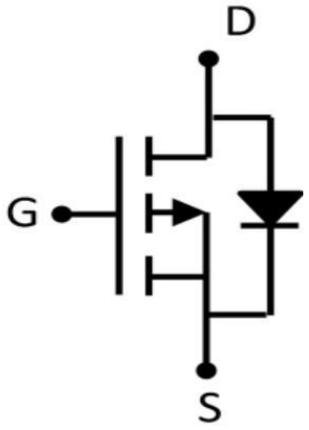
- Advanced Trench cell design
- Low Thermal Resistance
- Low Gate Charge
- Halogen-Free & Lead-Free
- 100% EAS Test
- 100% Rg Test

**Applications**

- Motor/Body Load Control
- Load Switch
- PWM Application
- DC/DC converters and Off-line UPS

**Pin Configuration**

LSR4407S8(SOP-8)			
 <p style="text-align: center;">Top View</p>			
<b>Pin</b>	<b>Description</b>	<b>Pin</b>	<b>Description</b>
1	Source	5	Drain
2	Source	6	Drain
3	Source	7	Drain
4	Gate	8	Drain



**Marking Information**

Part Marking	Part Number	LFC code
Q4407 YWWXXX	Q4407	YWWXXX

**Absolute Maximum Ratings**

 ( $T_A=25^{\circ}\text{C}$  Unless otherwise noted)

Symbol	Parameter	Typical	Unit
$V_{DSS}$	Drain-Source Voltage	-30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current	$T_A=25^{\circ}\text{C}$	-12
		$T_A=70^{\circ}\text{C}$	-10
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	-48	A
IAS	Avalanche Current	-27.2	A
EAS	Single Pulse Avalanche Energy <sup>2</sup>	115	mJ
$P_D$	Power Dissipation	1.4	W
$T_J$	Operating Junction Temperature Range	-55 to +150	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^{\circ}\text{C}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient <sup>3</sup>	89	$^{\circ}\text{C}/\text{W}$

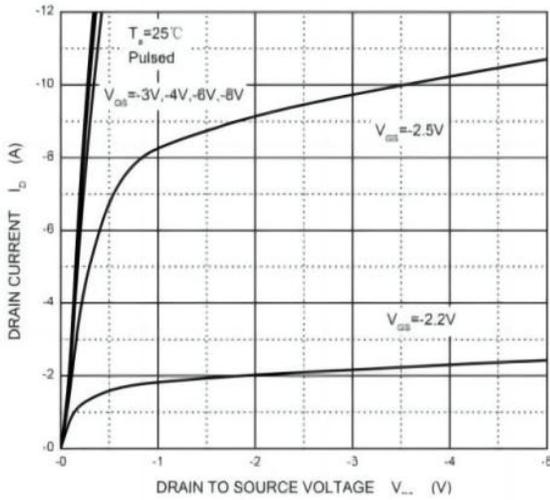
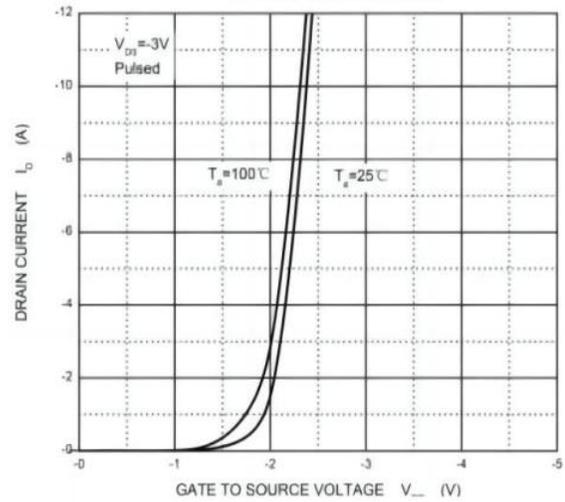
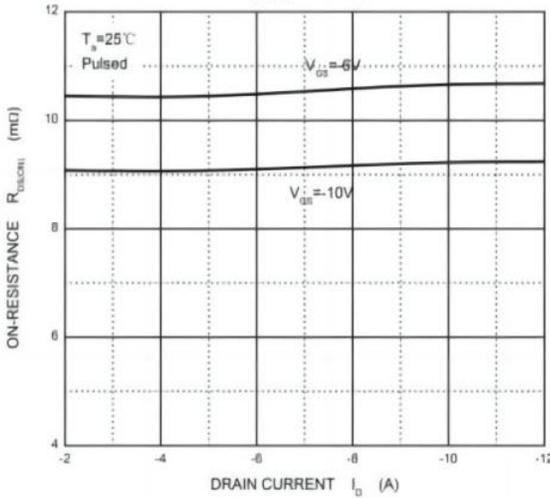
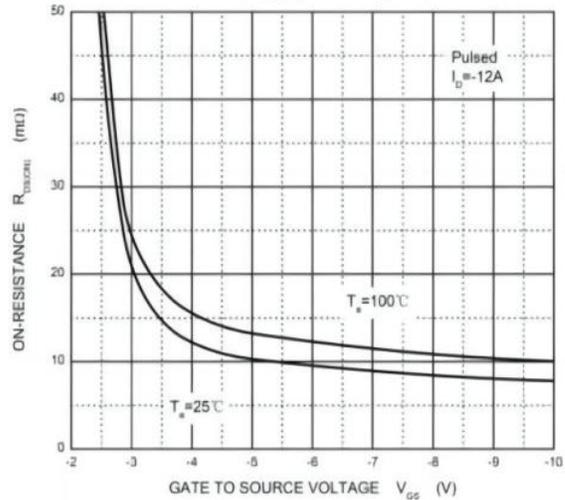
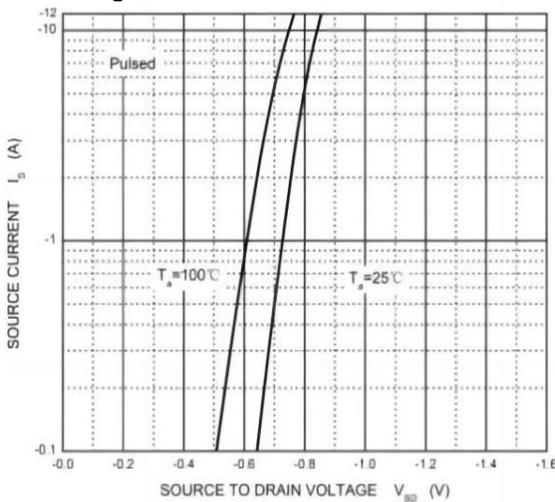
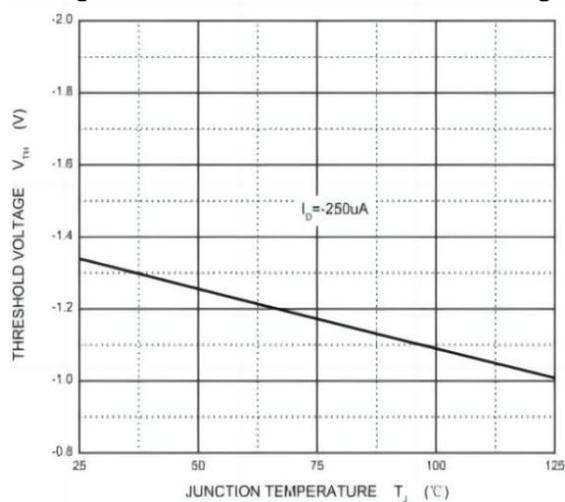
**Note:**

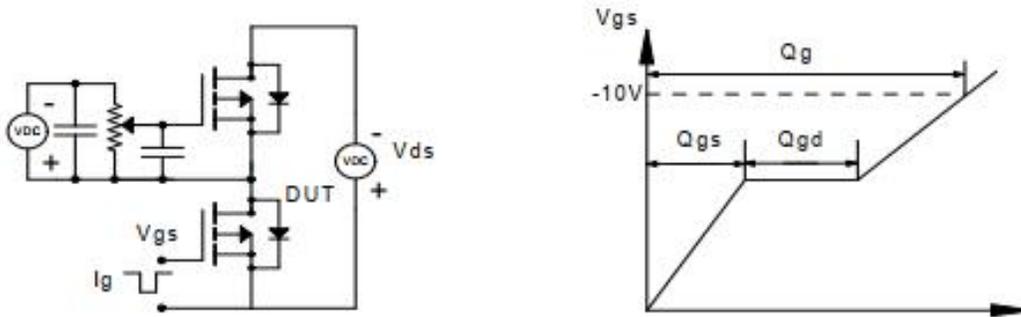
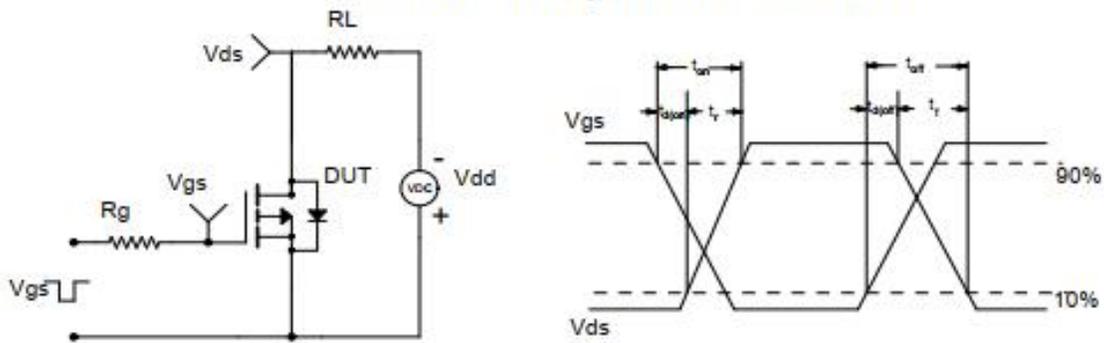
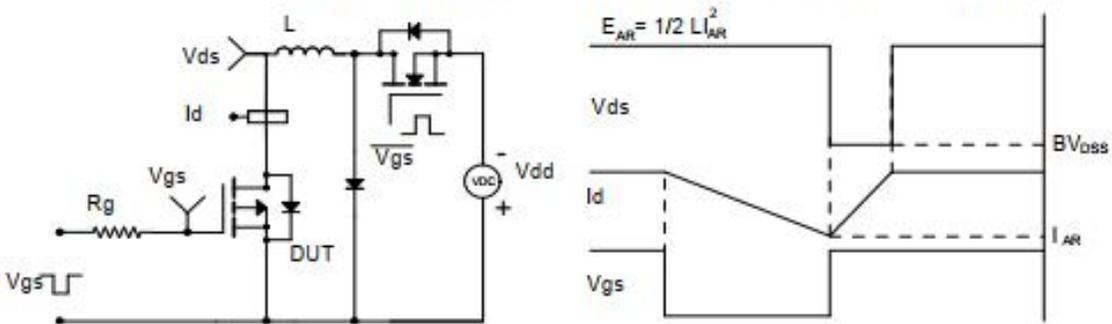
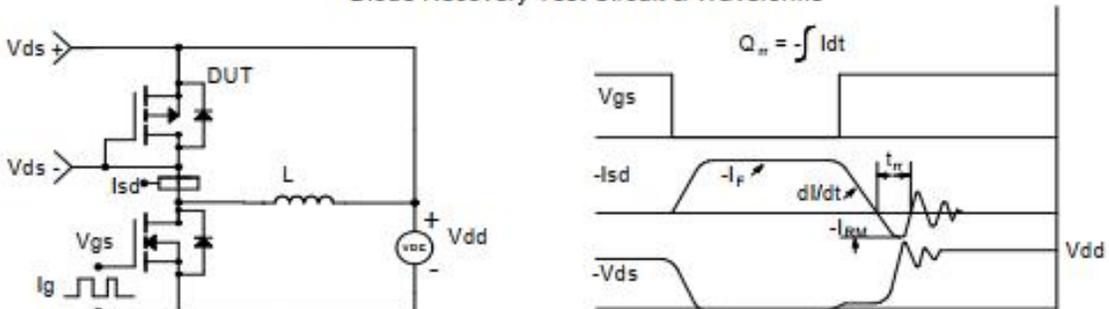
1. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ , Limited by  $T_{J(MAX)}$ .
2. Limited by  $T_{J(MAX)}$ , starting  $T_J = 25^{\circ}\text{C}$ ,  $L = 0.5\text{mH}$ ,  $R_g = 25\Omega$ ,  $I_D = -27.2\text{A}$ ,  $V_{GS} = -10\text{V}$ .
3. Device mounted on single sided FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air.

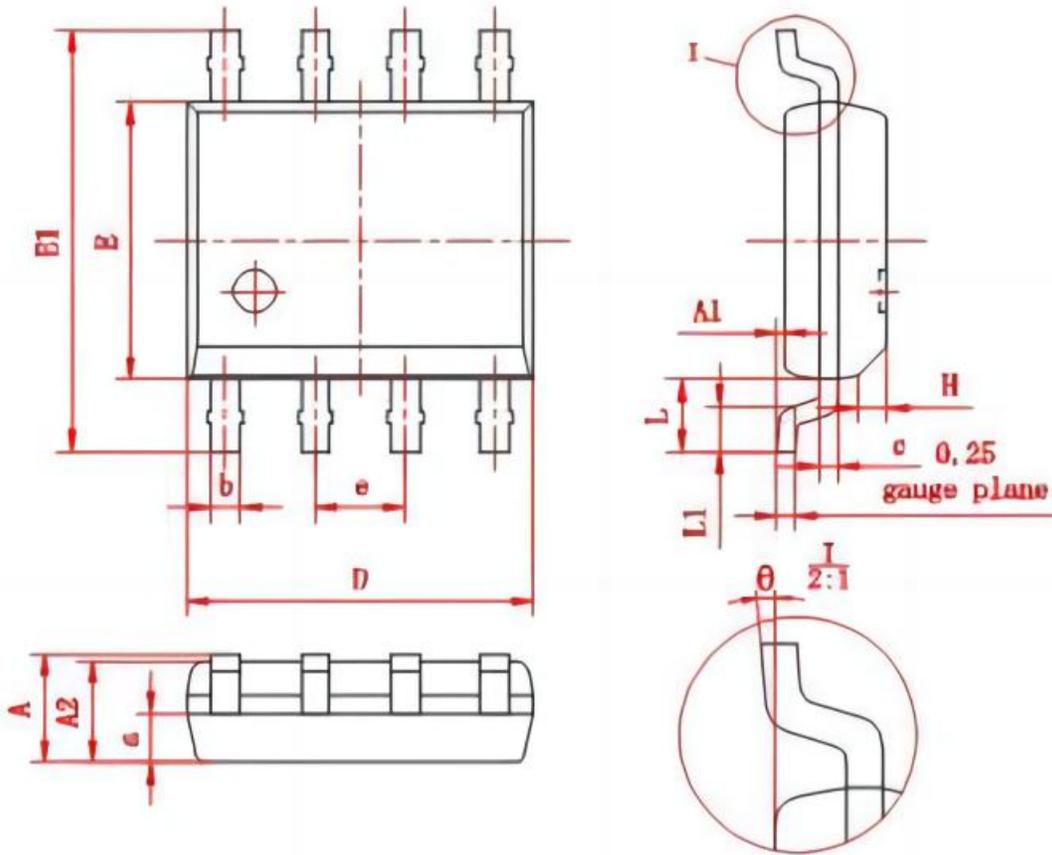
**Electrical Characteristics**

 (T<sub>A</sub>=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	-30			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	-1.0	-1.6	-2.5	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V			-1	uA
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-8A		9.8	13	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A		14.6	21	
<b>Dynamic</b>						
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz		6		Ω
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-15A		28		S
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz		2900		pF
C <sub>oss</sub>	Output Capacitance			410		
C <sub>rss</sub>	Reverse Transfer Capacitance			280		
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-15V, V <sub>GS</sub> =-10V, I <sub>D</sub> =-10A		48		nC
Q <sub>gs</sub>	Gate-Source Charge			12		
Q <sub>gd</sub>	Gate-Drain Charge			14		
t <sub>d(on)</sub>	Turn-On Time	V <sub>DS</sub> =-15V, V <sub>GS</sub> =-10V, R <sub>L</sub> =1.25Ω, R <sub>g</sub> =3Ω		15		ns
T <sub>r</sub>				11		
t <sub>d(off)</sub>	Turn-Off Time			44		
T <sub>f</sub>				21		
<b>Body-Diode</b>						
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =-2A			-1.2	V
trr	Body Diode Reverse Recovery Time	I <sub>S</sub> =-10A, di/dt=500A/us		11.5		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>S</sub> =-10A, di/dt=500A/us		25		nC

**Typical Performance Characteristics**

**Fig.1 Typical Output Characteristics**

**Fig.2 Typical Transfer Characteristics**

**Fig.3 On-Resistance vs. Drain Current**

**Fig.4 On-Resistance vs. Gate-Source Voltage**

**Fig.5 Source Current vs. Vsd**

**Fig.6  $V_{GS(th)}$  vs. Junction Temperature**

**Typical Characteristics**
**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**

**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**Diode Recovery Test Circuit & Waveforms**


**Package Dimension(Units:mm)**
**SOP-8**


Symbol	Min	Max	Symbol	Min	Max
A	1.35	1.75	H	0.40 BSC	
A1	0.10	0.25	e	1.27 BSC	
A2	1.35	1.55	b	0.30	0.50
a	0.70 BSC		c	0.18	0.30
D	4.70	5.10	L	1.00 BSC	
E	3.80	4.10	L1	0.40	0.80
E1	5.80	6.20	θ	0°	8°